

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/789,467	STELZER ET AL.	
Examiner		Art Unit		Page 1 of 1
Binh-An D. Nguyen		3713		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0019984	02-2002	Rakib, Selim Shlomo	725/111
	B	US-6,921,336 B1	07-2005	Best, Robert M.	463/32
	C	US-5,999,808	12-1999	LaDue, Christoph Karl	455/412.2
	D	US-6,872,139 B2	03-2005	Sato et al.	463/39
	E	US-5,855,483 A	01-1999	Collins et al.	434/322
	F	US-6,008,777 A	12-1999	Yiu, Timothy C.	345/2.1
	G	US-6,907,029 B2	06-2005	Brabrand, Tord	370/347
	H	US-2003/0104865 A1	06-2003	Itkis et al.	463/39
	I	US-5,695,400	12-1997	Fennell et al.	463/42
	J	US-5,702,305	12-1997	Norman et al.	463/42
	K	US-6,524,189 B1	02-2003	Rautila, Heikki	463/40
	L	US-6,874,003 B2	03-2005	Morohashi, Akihiro	707/204
	M	US-5,881,366 A	03-1999	Bodenmann et al.	455/41.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.